



**MS AF
RESPONSE UNDER 37 CFR 1.116
EXPEDITED PROCEDURE
EXAMINING GROUP 2829**

**PATENT
0763-0174P**

IN THE U.S. PATENT AND TRADEMARK OFFICE

APPLICANT: Ha Zoong KIM CONF.: 1610
APPL. NO.: 09/995,680 GROUP: 2829
FILED: November 29, 2001 EXAMINER: Karlsen, E.
FOR: TDDb TEST PATTERN AND METHOD FOR TESTING
TDDb OF MOS CAPACITOR DIELECTRIC

RESPONSE UNDER 37 C.F.R. 1.116

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

March 23, 2004

Sir:

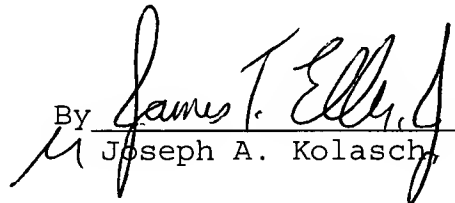
In response to the Examiner's Office Action dated December 23, 2003, the following amendments and remarks are respectfully submitted in connection with the above-identified application. The present Amendment includes changes to the claims and remarks.

- ☐ Petition for () month(s) extension of time pursuant to 37 C.F.R. §§ 1.17 and 1.136(a). \$0.00 for the extension of time.
- ☒ No fee is required.
- ☐ Check(s) in the amount of \$0.00 is(are) enclosed.
- ☐ Please charge Deposit Account No. 02-2448 in the amount of \$0.00. This form is submitted in triplicate.

If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to Deposit Account No. 02-2448 for any additional fees required under 37 C.F.R. §§1.16 or 1.17; particularly, extension of time fees.

Respectfully submitted,

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JAK/RFG/gf
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Attachment(s)

(Rev. 02/08/2004)